



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Chun Tse, et al. :
Serial No: 10/697,300 : Art Unit #2862
Filed: 31 October 2003 : Examiner
Title: SYSTEM AND METHOD FOR HIGH- : Unknown
SPEED MASSIVE MAGNETIC
IMAGING ON A SPIN-STAND

INFORMATION DISCLOSURE STATEMENT

Honorable Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

The Applicants wish to make the following art references of record in the above-identified Patent Application pursuant to 37 C.F.R. §§ 1.97 and 1.98, and to the Duty of Disclosure set forth in 37 C.F.R. § 1.56.

Although the information submitted herewith may be "material" to the Examiner's consideration of the subject Patent Application, this submission is not intended to constitute an admission that such information is "prior art" as to the claimed invention.

In accordance with 37 C.F.R. § 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search was made or that no other material information, as defined in 37 C.F.R. § 1.56(b), exists.

The Cited Publications are:

<u>Ref. No.</u>	<u>Description</u>
A1	I. Mayergoyz, et al., "Magnetic Imaging on a Spin-Stand", JOURNAL OF APPLIED PHYSICS, Vol. 87, No. 9, pgs 6824 - 6826, 1 May 2000.
B1	I. Mayergoyz, et al., "Spin-Stand Imaging of Overwritten Data and Its Comparison with Magnetic Force Microscopy", JOURNAL OF APPLIED PHYSICS, Vol. 89, No. 11, pgs 6772 - 6774, 1 June 2001.
C1	I. Mayergoyz, et al., "Spin-Stand Imaging of Transverse Magnetization Profiles of Recorded Tracks", JOURNAL OF APPLIED PHYSICS, Vol. 89, No. 11, pgs 6775 - 6777, 1 June 2001.
D1	C. Tse, et al., "Spatial and Vectorial Characterization of Thermal Relaxation Using the Spin-Stand Imaging Technique", JOURNAL OF APPLIED PHYSICS, Vol. 91, No. 10, pgs 8846 - 8848, 15 May 2002.

This Information Disclosure Statement is being filed more than three months subsequent to the Filing Date of the subject Patent Application, but before the mailing of a first Office Action.

MR2833-26
Serial Number: 10/697,300

A Form PTO-1449 and copies of the references are submitted along with this document. It is requested that the Examiner consider the references and make them of record in the above-referenced Patent Application.

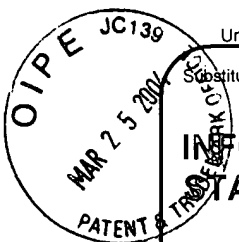
Respectfully submitted,
FOR: ROSENBERG, KLEIN & LEE

A handwritten signature in black ink, appearing to read "David I. Klein". The signature is fluid and cursive, with a large initial "D" and "K".

David I. Klein
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Dated: *24 March 2004*

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Complete if Known			
		Application Number	10/697,300		
		Filing Date	31 October 2003		
		First Named Inventor	Chun Tse, et al.		
		Art Unit	2862		
Examiner Name					
Sheet	1	of	1	Attorney Docket Number	MR2833-26

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	A1	I. Mayergoyz, et al., "Magnetic Imaging on a Spin-Stand", JOURNAL OF APPLIED PHYSICS, Vol. 87, No. 9, pgs 6824 - 6826, 1 May 2000.	
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	E1		
	F1		
	G1		
	H1		
	I1		
	J1		

Examiner Signature		Date Considered	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached. This collection of information is required by 37 CFR 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 120 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. **SEND TO: Commissioner for Patents, Washington, DC 20231.**

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